

Notice of References Cited	Application/Control No. 10/618,297	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner Patrick J. Lee	Art Unit 2878	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,814,931	06-1974	Kuroda et al.	250/223R
	B	US-			
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	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 03208348 A	09-1991	Japan	TABUCHI, ZENICHIRO	H01L 21/52
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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